

Test Report No: 10519172(1d) Date: 23-Jul-2021 Page 1 of 4

GLOBALFOUNDRIES Singapore Pte Ltd 60 Woodlands Industrial Park D Street 2 Singapore 738406

The following sample(s) was/were submitted and identified by/on behalf of the client as:

Sample Name : One (1) 300mm die-patterned wafer

Technode : 90nm/0.11um

Fab : 7

Sample Receiving Date : 13-Jul-2021

Testing Period : 13-Jul-2021 to 23-Jul-2021

Test Result(s) : Please refer to next page(s).

Signed for and on behalf of SGS Testing & Control Services Singapore Pte Ltd

Y.C. Tham

Technical Manager, Multi-Lab

Test Location: 30 Boon Lay Way, #02-02, Singapore 609957

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SGS Testing & Control Services Singapore Pte Ltd

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Co. Reg. No: 199404065N GST Reg. No: MR-8500112-9 Member of SGS Group



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Test Result(s):

Sample Description : Wafer

Test Item(s):	Unit	Method	Results	MDL
Antimony (Sb)		With reference to US EPA 3052. Analysis was performed by ICP/OES	n.d.	2

Note: (1) mg/kg = ppm ; 0.1wt% = 1000ppm

(2) n.d.= Not Detected

(3) MDL = Method Detection Limit

Remarks: Sample received was totally dissolved by pre-conditioning method.

Lab Analyst(s): Joela

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Sample photo:

Sample Description : Wafer

SGS authenticate the photo on original report only



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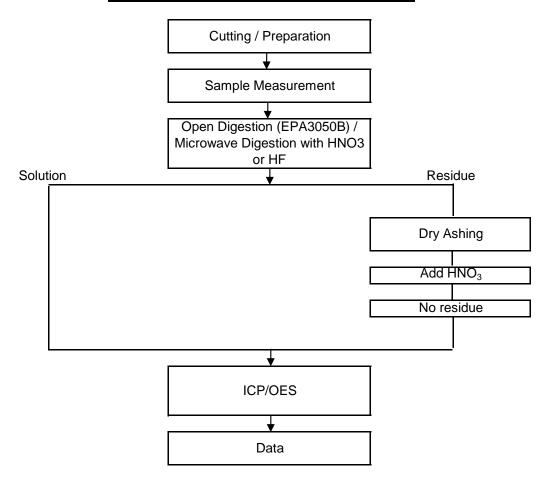
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Process Flow of US EPA 3050B/3051A/3052



End of Report

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